

AONS62814T

80V N-Channel AlphaSGT™

General Description

Trench Power AlphaSGT[™] technology

- Low R_{DS(ON)}
- Low Gate Charge
- Low Eoss

Product Summary

 $\begin{array}{lll} V_{DS} & 80V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 100A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.6 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 6V) & < 3.5 m\Omega \end{array}$

Applications

Orderable Part Number

Power Dissipation A T_A=70°C

Junction and Storage Temperature Range

• Secondary Synchronous Rectification MOSFET for Server and Telecom

100% UIS Tested 100% Rg Tested

Max Tj=175°C

Form

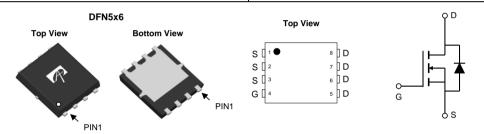
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-55 to 175



Minimum Order Quantity

°C



Package Type

AONS62814T		DFN 5x6	Tape & Reel	3000		
Absolute Maximun	n Ratings T _A =2	5°C unless otherwise noted				
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V _{DS}	80	V		
Gate-Source Voltage		V_{GS}	±20	V		
Continuous Drain	T _C =25°C		100			
Current ^G	T _C =100°C	ID	100	A		
Pulsed Drain Current ^C		I _{DM}	372			
Continuous Drain	T _A =25°C		40	۸		
Current	T _A =70°C	IDSM	33	A		
Avalanche Current ^C		I _{AS}	73	A		
Avalanche energy	L=0.1mH	E _{AS}	266	mJ		
Power Dissipation ^B	T _C =25°C	р	258	14/		
	T _C =100°C	P _D	129	W		
	T _A =25°C	р	8.8	10/		
Dower Dissinction A	T _70°C	P _{DSM}	6.1	W		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	14	17	°C/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	50	°C/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.43	0.58	°C/W			

 T_J, T_{STG}



Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

Symbol	Parameter Conditions			Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		80			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =80V, V_{GS} =0V				1	μA
	Zero Gate Voltage Drain Gunerit	T _J =55°C				5	μΛ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V	V _{DS} =0V, V _{GS} =±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS, I_D}=250\mu A$		2.1	2.6	3.2	V
		V _{GS} =10V, I _D =20A			2.2	2.6	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance		T _J =125°C		3.7	4.5	11122
		V_{GS} =6V, I_D =20A			2.8	3.5	mΩ
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$			100		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.68	1	V
Is	Maximum Body-Diode Continuous Curi			100	Α		
DYNAMI	CPARAMETERS		-		-	-	
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =40V, f=1MHz			4940		pF
Coss	Output Capacitance				770		pF
C_{rss}	Reverse Transfer Capacitance				40		pF
R_g	Gate resistance	f=1MHz		0.3	0.7	1.2	Ω
SWITCH	NG PARAMETERS		-		-	-	
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =40V, I _D =20A			68	100	nC
Q_{gs}	Gate Source Charge				14.5		nC
Q_{gd}	Gate Drain Charge				14		nC
t _{D(on)}	Turn-On DelayTime				14		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =40V, R_L =2.0 Ω , R_{GEN} =3 Ω			8.5		ns
$t_{D(off)}$	Turn-Off DelayTime				40		ns
t _f	Turn-Off Fall Time		_	10		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs			32		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs			168		nC

A. The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} \(\square 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)} = 175^\circ$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =175° C.

D. The $R_{\theta,JA}$ is the sum of the thermal impedance from junction to case $R_{\theta,JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

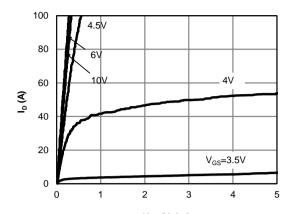
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

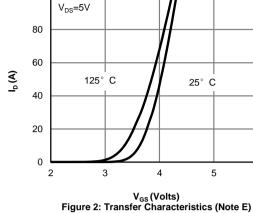
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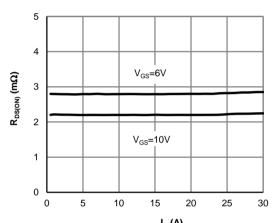
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



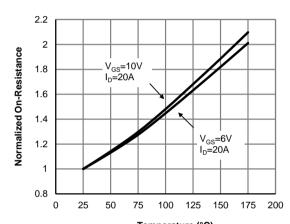
V_{DS} (Volts) Figure 1: On-Region Characteristics (Note E)



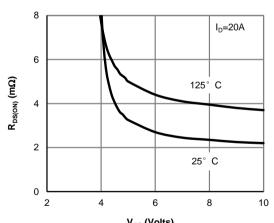
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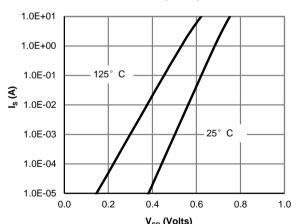
 $\label{eq:local_potential} \mathbf{I_{D}}\left(\mathbf{A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



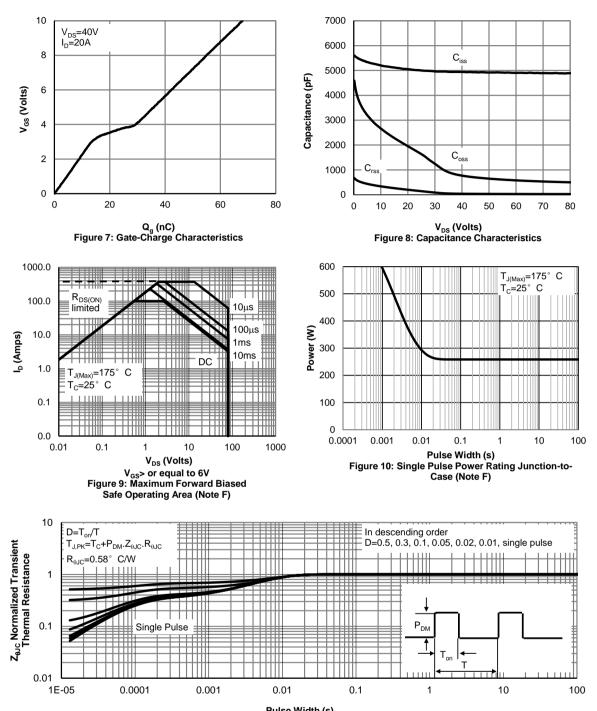
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



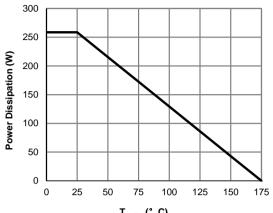
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

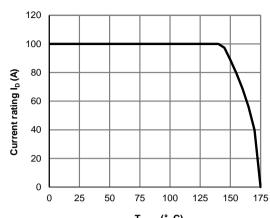


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



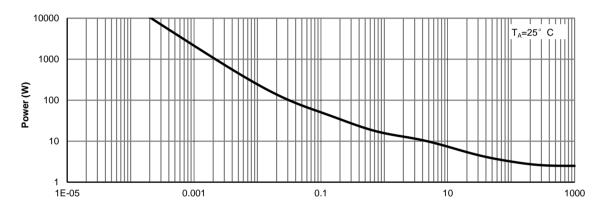
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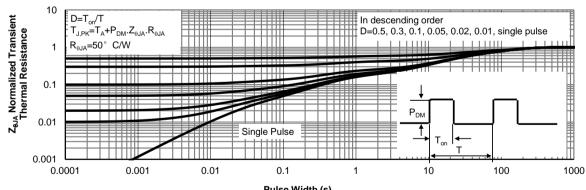


T_{CASE} (° C)
Figure 12: Power De-rating (Note F)

T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



Pulse Width (s)
Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

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Figure A: Gate Charge Test Circuit & Waveforms

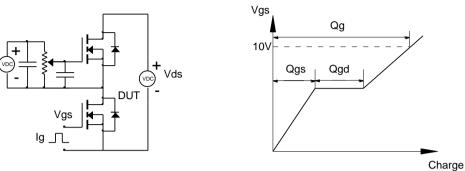


Figure B: Resistive Switching Test Circuit & Waveforms

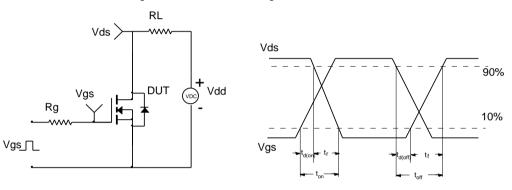


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

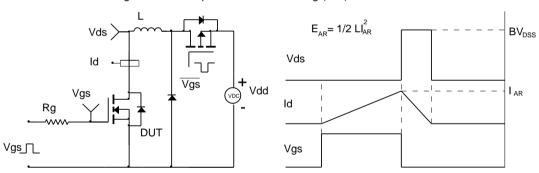
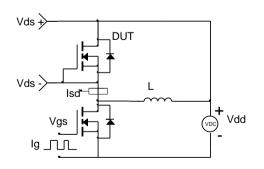
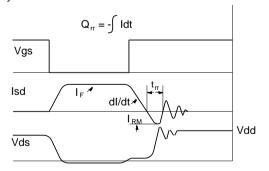


Figure D: Diode Recovery Test Circuit & Waveforms





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